

Notice of References Cited	Application/Control No. 10/749,532	Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner T. D. Wessendorf	Art Unit 1639	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0113714 A1	06-2003	Belcher et al.	435/5
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
<input checked="" type="checkbox"/>	U	Freeman et al, Science, 267, 1995, 1629-1632.□□□□
<input type="checkbox"/>	V	Puntes et al, Science, 291, 3/2001, 2115-17.
<input type="checkbox"/>	W	Lee et al, Sience, 296,5/2002, 892-95
<input type="checkbox"/>	X	Naik et al, Nature, 2002, 169-172.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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